

<b>Search Notes</b>	<b>Application/Control No.</b>	<b>Applicant(s)/Patent Under Reexamination</b>
	10042231	NAKANO, MASAKI
	<b>Examiner</b>	<b>Art Unit</b>
	AARON M RICHER	2628

### SEARCHED

<b>Class</b>	<b>Subclass</b>	<b>Date</b>	<b>Examiner</b>
345	588 - updated	4/15/08	AMR

### SEARCH NOTES

<b>Search Notes</b>	<b>Date</b>	<b>Examiner</b>
EAST (US-PGPUB; USPAT; EPO; JPO; DERWENT, IBM_TDB) - see search history printout	4/15/08	AMR

### INTERFERENCE SEARCH

<b>Class</b>	<b>Subclass</b>	<b>Date</b>	<b>Examiner</b>